

<b>Notice of References Cited</b>	Application/Control No. 10/750,924		Applicant(s)/Patent Under Reexamination JALLOUL ET AL.	
	Examiner Dominic E. Rego		Art Unit 2684	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0093178	05-2004	Shin et al.	702/069
*	B	US-2005/0075122	04-2005	Lindoff et al.	455/522
*	C	US-2003/0031195	02-2003	OKAWA et al.	370/441
*	D	US-6,370,130	04-2002	Zhou et al.	370/335
*	E	US-2001/0019577	09-2001	Ha, Ji-Won	375/148
*	F	US-6,320,915	11-2001	Stott et al.	375/340
*	G	US-2004/0266469	12-2004	Hayashi et al.	455/522
*	H	US-2005/0037712	02-2005	Rainbolt et al.	455/067.11
*	I	US-2004/0127213	07-2004	Hwang, Bong Jun	455/423
*	J	US-6,865,218	03-2005	Sourour, Essam A	375/148
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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